

Abstract Submitted  
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**Criticality in Trapped Atomic Systems**<sup>1</sup> NIKOLAY PROKOFIEV,  
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Amherst, LODE POLLET, Theoretische Physik, ETH Zurich — We discuss generic  
limits posed by the trap in atomic systems on the accurate determination of crit-  
ical parameters for second-order phase transitions, from which we deduce optimal  
protocols to extract them. We show that under current experimental conditions the  
in-situ density profiles are barely suitable for an accurate study of critical points in  
the strongly correlated regime. Contrary to recent claims, the proper analysis of  
time-of-flight images yields critical parameters accurately. L. Pollet, N. Prokof'ev,  
and B. Svistunov, Phys. Rev. Lett. 104, 245705 (2010).

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